ICT/FCT TEST PROBES

Test Probe INGUN E-Type

E-050 214 050 A 2000

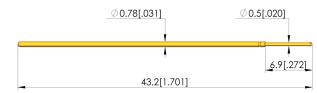
Item E-050-0004





- Highest contact reliability under challenging test conditions without additional stress on the DUT: up to 25% larger contact surface between test probe and DUT
- When hitting the test surface a spring force up to 100% higher than a standard GKS is available, but the same spring force as a standard GKS is achieved at the working stroke.
- Dimensions equivalent to the standard GKS series







General data

Product group: ICT / FCT (in-circuit test and function test Sub-product group: INGUN E-TYPE® Series: E-050 Grid: 1.27 mm [50 mil] Contacting from: Pad Magnetic: Installation type: Plug-in Quick-exchange system: Yes Adjustable installation height: No Non-rotating: No Compatible receptacle(s): KS-050 Min. temperature: -40 °C [-40 °F] Max. temperature: 80 °C [176 °F] RoHS-compliant: Yes

Tip style data

Tip style:	14 4-point crown, self-cleaning
Tip diameter:	0.5 mm [.019 in]
Tip style surface:	A gold
Tip style material:	2 steel

Electrical data

Current load capacity / rated current: 2 A Typical resistance (Ri): 20 mOhm

Mechanical data

Total length:	43.2 mm [1.7 in]
Barrel diameter:	0.78 mm [.03 in]
Maximum stroke:	6.35 mm [.25 in]
Spring pre-load:	1.09 N [3.92 ozf]
Collar height:	00
Spring force at working stroke:	2 N [7.19 ozf]
Recommended working stroke:	4.3 mm [.169 in]

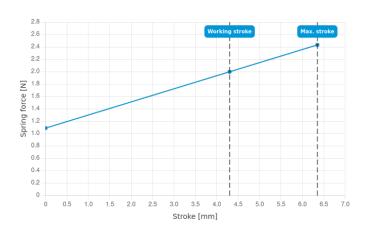
Partner for Future Technology

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Learn more about **ICT/FCT Test probes**

